## Reexamination 09/516,268 AHRENS ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2874 John D. Lee U.S. PATENT DOCUMENTS Document Number Date \* Classification Name Country Code-Number-Kind Code MM-YYYY \* Christian et al. 250/201.1 US-3,781,546 12-1973 Α \* 385/78 US-4,188,087 02-1980 D'Auria et al. В \* 398/156 09-1987 LaBudde, Edward V. US-4,696,062 С 250/201.1 04-1992 Fonneland et al. D US-5,103,082 US-Ε US-F G US-US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date \* Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

Application/Control No.

Applicant(s)/Patent Under

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.